Searcn Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/031,067	MALIK ET AL.
Examiner	Art Unit
Young J. Kim	1637

SEARCHED				
Class	Subclass	Date	Examiner	
			:	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB) see enclosed for text-search strategies	11/17/2005	YJK	
SEQ ID NO: 1, 2, 3, 4, 8, and 9 via STIC Library. See enclosed for search parameters.	11/17/2005	YJK	
Inventor name search: Karim Malik; and Keith Brown	11/17/2005	YJK	
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